

**Search Notes**

Application/Control No.

10/823,625

Examiner

Richard Bueker

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

1763

**SEARCHED**

Class	Subclass	Date	Examiner
118	726	3/20/2005	RRB
261	121.1	3/20/2005	RRB
above	updated	10/25/2005	RRB
above	updated	4/14/2006	RRB
55	485	4/16/2006	RRB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR